

Search Notes

Application/Control No.

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Examiner

Yalkew Fantu

Applicant(s)/Patent under
Reexamination

DEHAAN ET AL.

Art Unit

2838

SEARCHED

Class	Subclass	Date	Examiner
320	134,122,1 32	3/27/2007	YF

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search history with text	3/27/2007	YF